

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10543111	CAWTHON, RICHARD
Examiner	Art Unit	
Young J Kim	1637	

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
Patent Databases (USPT, USPPGP, EPO, JPO, DERWENT, IBM-TDB) see enclosed for text-search strategy	1/17/2009	/YJK/
	1/17/2009	/YJK/

INTERFERENCE SEARCH

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	/Young J Kim/ Primary Examiner, Art Unit 1637
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